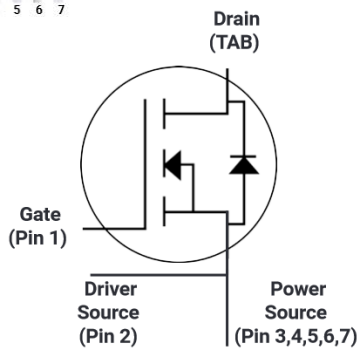


Silicon Carbide Power MOSFET (N-Channel Enhancement)

V_{DS}	1200V
I_D (25°C)	42A
$R_{DS(on)}$	60mΩ



Features

- High speed switching
- Essentially no switching losses
- Reduction of heat sink requirements
- Maximum working temperature at 175 °C
- High blocking voltage
- Fast Intrinsic diode with low recovery current
- High-frequency operation
- Halogen free, RoHS compliant
- AEC-Q101 qualified

Typical Applications

Typical applications are in power factor correction(PFC), solar inverter, uninterruptible power supply, motor drives, photovoltaic inverter, electric car and charger.

Mechanical Data

- **Package:** TO263-7L
- **Terminals:** Tin plated leads
- **Polarity:** As marked

■Maximum Ratings ($T_C=25^\circ\text{C}$ Unless otherwise specified)

PARAMETER	SYMBOL	UNIT	VALUE	TEST CONDITIONS	NOTE
Device marking code			D212060B7GH		
Drain source voltage @ $T_j=25^\circ\text{C}$	$V_{DS,max}$	V	1200	$V_{GS}=0\text{ V}$, $I_D=100\mu\text{A}$	
Gate source voltage @ $T_j=25^\circ\text{C}$	$V_{GS,max}$	V	-10/+25	Absolute maximum values (AC f > 1Hz, duty cycle < 1%)	
Gate source voltage @ $T_j=25^\circ\text{C}$	$V_{GS,op}$	V	-5/+20	Recommended operational values	
Continuous drain current @ $T_c=25^\circ\text{C}$	I_D	A	42	$V_{GS}=20\text{V}$, $T_c=25^\circ\text{C}$	Fig.14
Continuous drain current @ $T_c=110^\circ\text{C}$			29	$V_{GS}=20\text{V}$, $T_c=110^\circ\text{C}$	
Pulsed drain current	$I_{D(pulsed)}$	A	88.5	Pulse width t_p limited by $T_{j,max}$	Fig.15
Avalanche energy, Single Pulse	E_{AS}	mJ	400	$V_{DD}=75\text{V}$, $L=30\text{mH}$	
Power Dissipation	P_{TOT}	W	234	$T_c=25^\circ\text{C}$, $T_j = 175^\circ\text{C}$	Fig.13
Operating junction and Storage temperature range	T_j, T_{stg}	$^\circ\text{C}$	-55 to +175		
Soldering temperature	T_L	$^\circ\text{C}$	260	1.6mm (0.063") from case for 10s	



■Static Electrical Characteristics (Tc=25°C unless otherwise specified)

PARAMETER	SYMBOL	UNIT	Min.	Typ.	Max.	Test Conditions	Note
Gate threshold voltage	$V_{GS(th)}$	V	1.5	2.8	4.0	$V_{DS}=10V, I_D=20mA$	Fig.4, 11
Drain source breakdown voltage	$V_{(BR)DSS}$	V	1200			$V_{GS}=0V, I_D=100\mu A$	
Zero gate voltage drain current	I_{DSS}	μA		<1	50	$V_{DS}=1200V, V_{GS}=0V$	
				10	500	$V_{DS}=1200V, V_{GS}=0V, T_J=175^\circ C$	
Gate source leakage current	I_{GSS}	nA			250	$V_{GS}=20V, V_{DS}=0V$	
Current drain source on-state resistance	$R_{DS(on)}$	$m\Omega$		66	80	$V_{GS}=20V, I_D=20A$	Fig.3, 5, 6
				100		$V_{GS}=20V, I_D=20A, T_J=175^\circ C$	
Transconductance	g_f	S		7.7		$V_{DS}=20V, I_D=20A$	

■Dynamic Electrical Characteristics (Tc=25°C unless otherwise specified)

PARAMETER	SYMBOL	UNIT	Min.	Typ.	Max.	Test Conditions	Note
Input capacitance	C_{iss}	pF		2200		$V_{DS}=800V, V_{GS}=0V, T_J=25^\circ C, f=1MHz, V_{AC}=25mV$	Fig.10
Output capacitance	C_{oss}			115			
Reverse capacitance	C_{rss}			18.5			
Coss stored energy	E_{oss}	μJ		47			Fig.12
Gate source charge	Q_{gs}	nC		29		$V_{DS}=800V, V_{GS}=-5/20V, I_D=20A$	Fig.16
Gate drain charge	Q_{gd}			64			
Gate charge	Q_g			129			
Short-Circuit Withstand Time	t_{sc}	μs		3.6		$R_g=30\Omega, I_D=376A, V_{GS}=-5/20V, V_{DD}=800V$	
Internal Gate Resistance	$R_{G(int)}$	Ω		2.0	5.0	$f=1MHz, V_{AC}=25mV$	

■Switching Characteristics (Tc=25°C unless otherwise specified)

PARAMETER	SYMBOL	UNIT	Min.	Typ.	Max.	Test Conditions	Note
Turn on delay time	$t_{d(on)}$	ns		5.9		$V_{DD}=800V, V_{GS}=-5/+20V, I_D=20A, L=100\mu H, R_{G(ext)}=2.7\Omega$	Fig.17, 18
Rise time	t_r			15			
Turn off delay time	$t_{d(off)}$			17.3			
Fall time	t_f			10			
Turn on switching energy	E_{on}	μJ		300			
Turn off switching energy	E_{off}			45			



■Body diode characteristics (Tc=25°C unless otherwise specified)

PARAMETER	SYMBOL	UNIT	Min.	Typ.	Max.	Test Conditions	Note
Diode forward voltage	V _{SD}	V		4.0		V _{GS} =0V, I _{SD} =10A	Fig.8
Continuous diode forward current	I _S	A		43		V _{GS} =0V, Tc=25°C	
Reverse recovery time	t _{rr}	nS		57		V _{DS} =400V, V _{GS} =0V, I _{SD} =10A, di/dt=300A/uS	
Reverse recovery charge	Q _{rr}	nC		109			
Peak reverse recovery current	I _{rrm}	A		3.5			

■Thermal Characteristics (T_a=25°C Unless otherwise specified)

PARAMETER	SYMBOL	UNIT	Value
Thermal resistance	R _{θJ-C}	°C/W	0.64

■Typical Characteristics

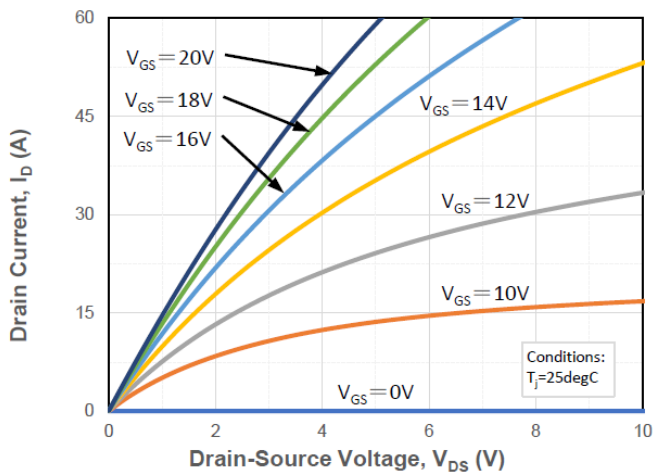


Figure 1. Output Characteristics Tj = 25°C

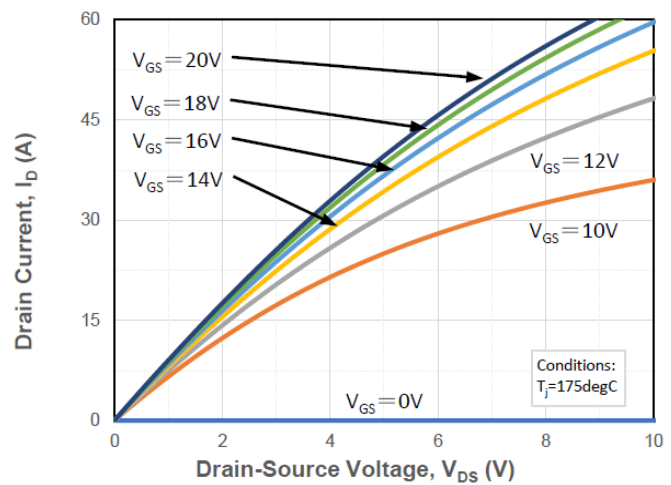


Figure 2. Output Characteristics Tj = 175°C

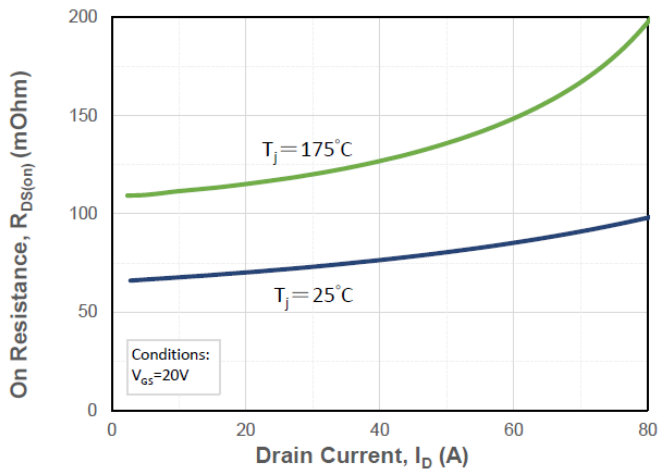


Figure 3. On-resistance vs. drain current

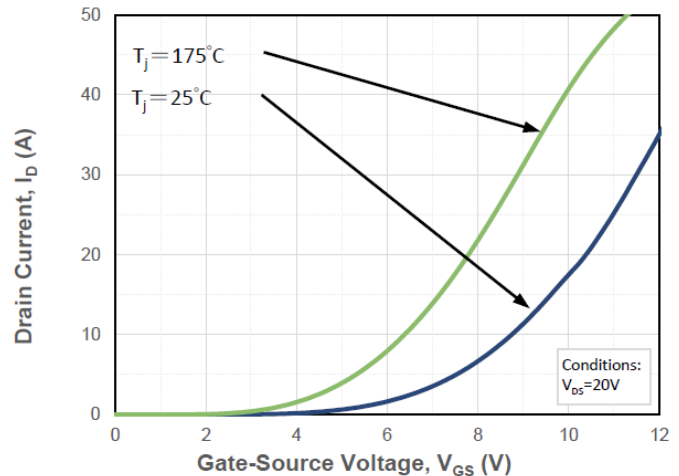


Figure 4. Transfer Characteristics for various Tj

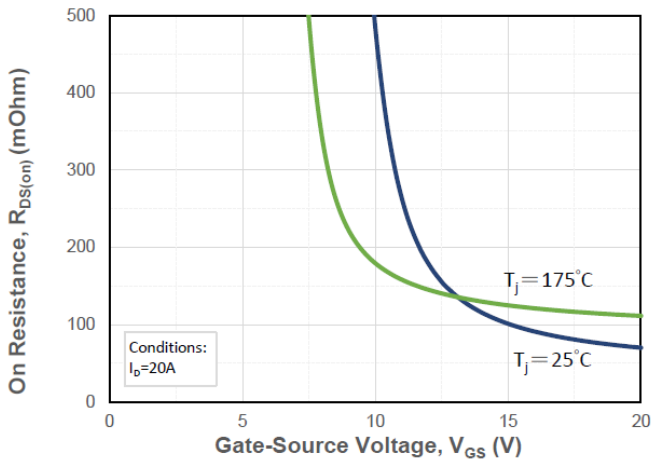


Figure 5. On-resistance vs. gate voltage for various Tj Gate voltage

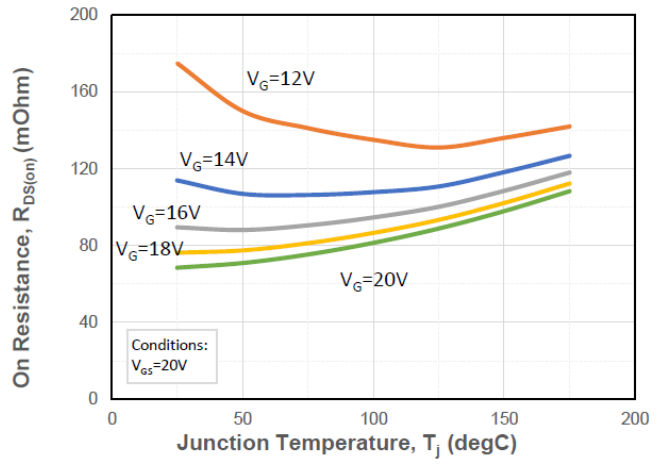


Figure 6. On-resistance vs. Temperature for various Gate voltage

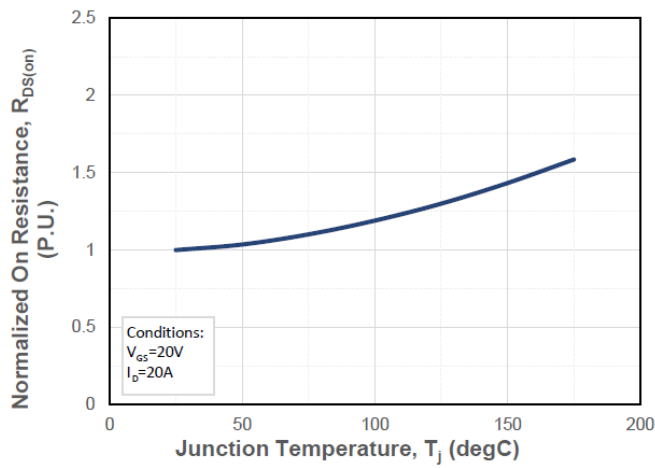


Figure 7. Normalized On-Resistance vs. Temperature

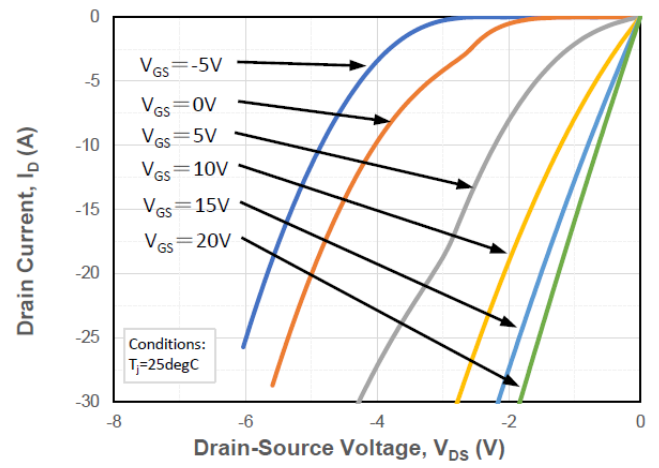


Figure 8. Reverse Output Characteristics at Tj = 25°C

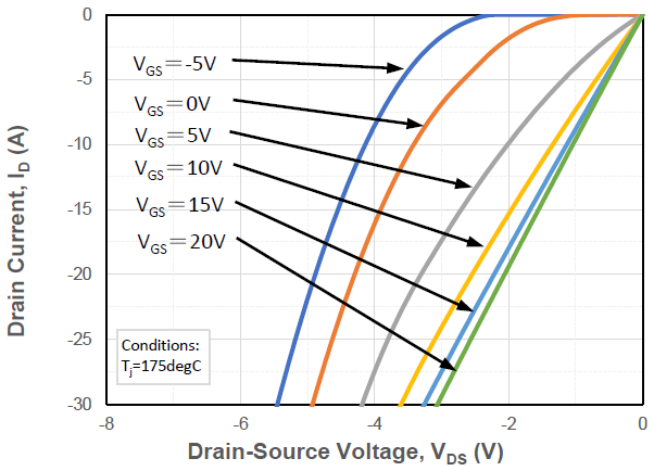


Figure 9. Reverse Output Characteristics at Tj = 175°C

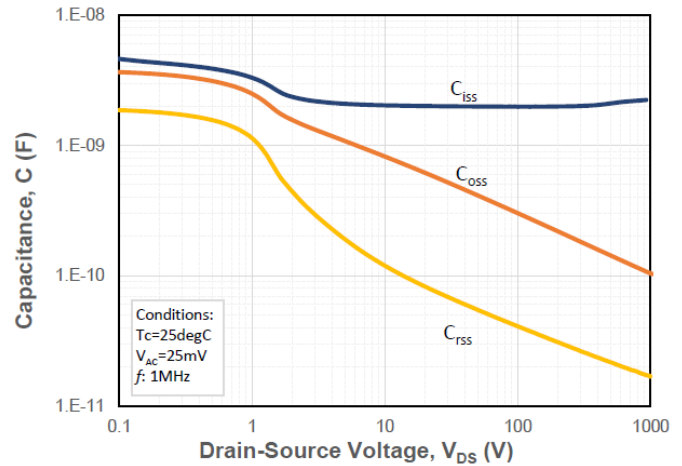


Figure 10. Capacitances vs. Drain to Source Voltage

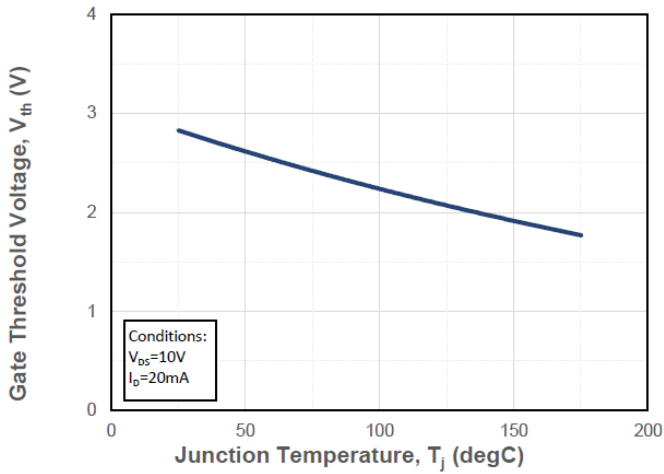


Figure 11. Threshold voltage vs.temperature

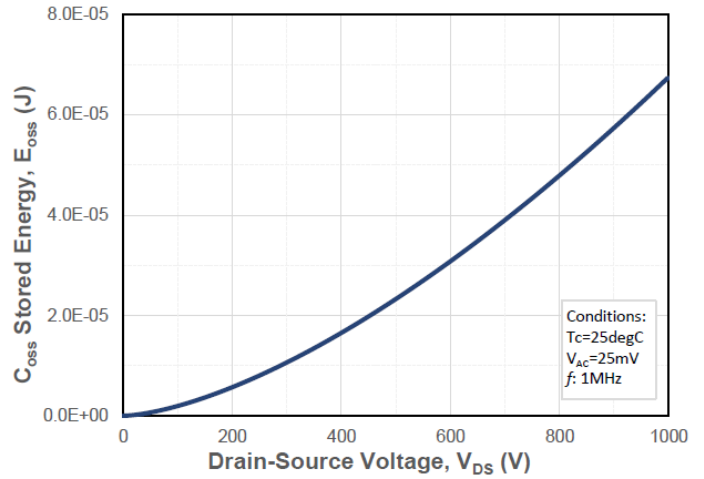


Figure 12. Output Capacitor Stored Energy

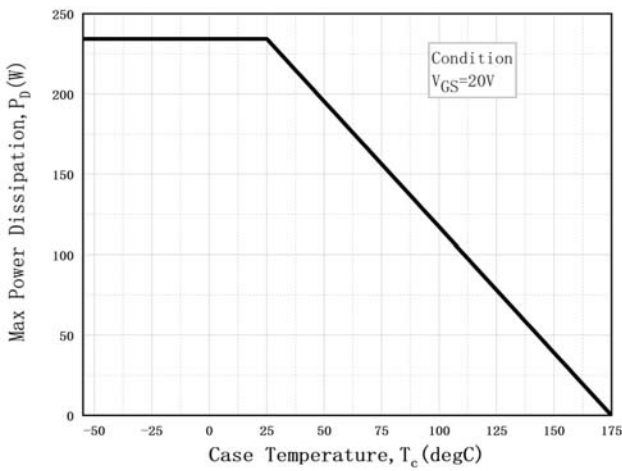


Figure 13. Maximum Power Dissipation Derating vs. Case Temperature

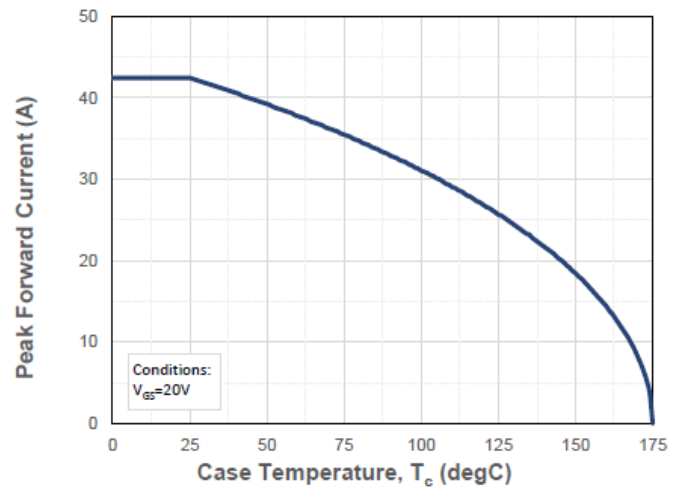


Figure 14. Drain Current Derating vs. Case Temperature

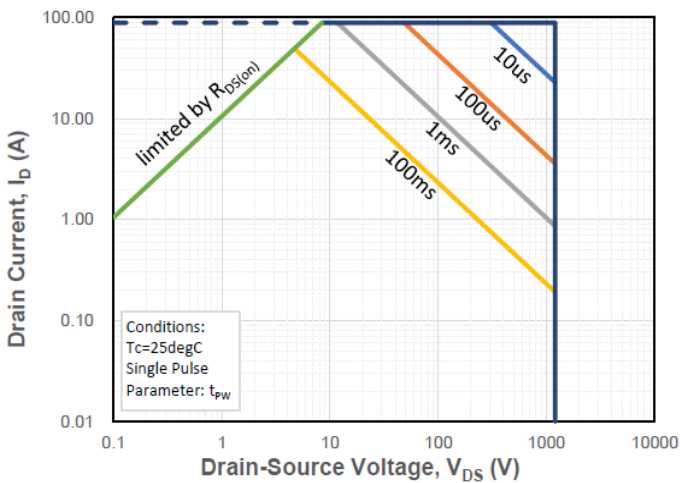


Figure 15. Safe Operating Area

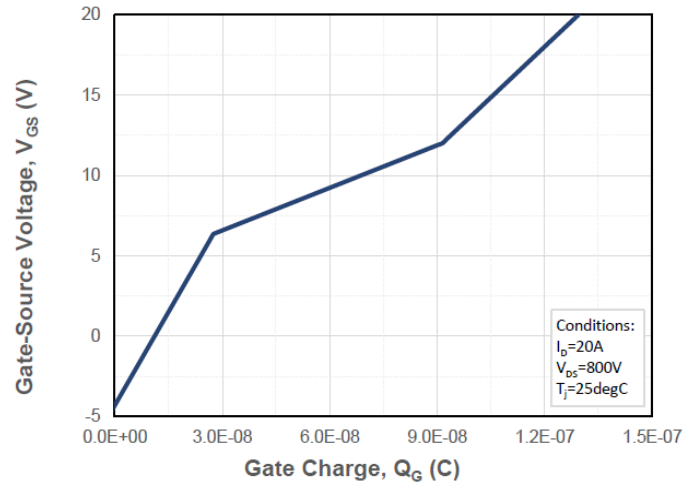


Figure 16. Gate Charge Characteristics

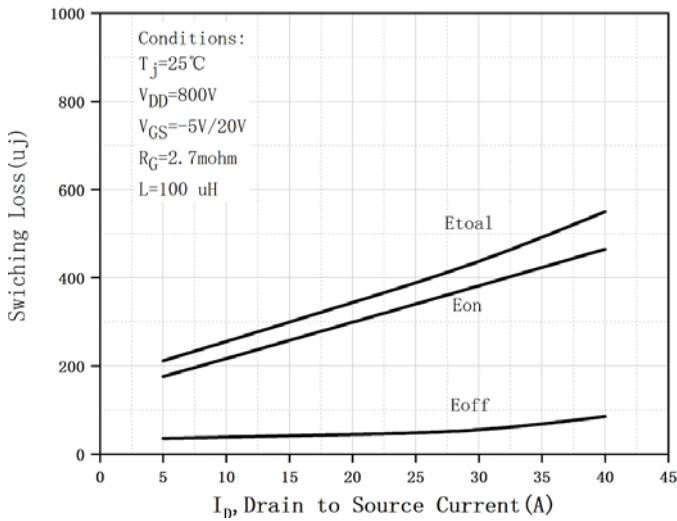


Figure 17. Clamped Inductive Switching Energy vs. Drain Current

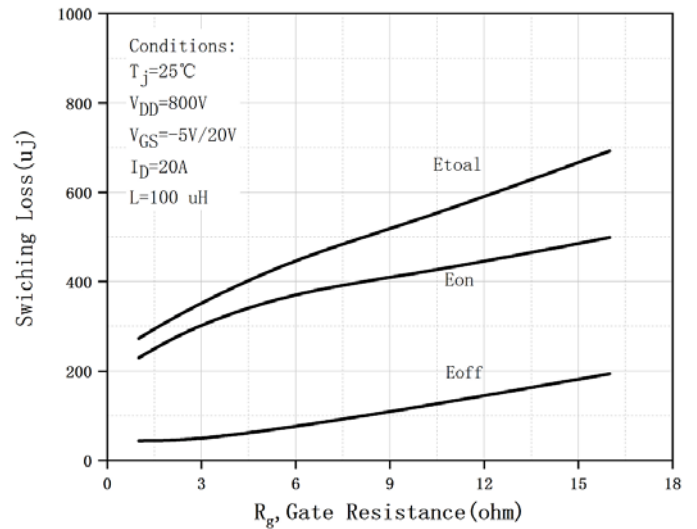


Figure 18. Clamped Inductive Switching Energy vs. External Gate Resistor ($R_{G(\text{ext.})}$)

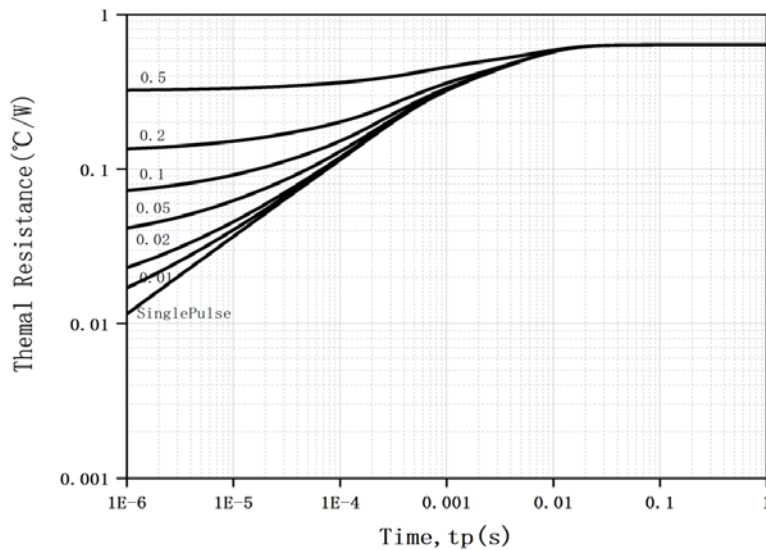


Figure 19. Transient Junction to Case Thermal Impedance

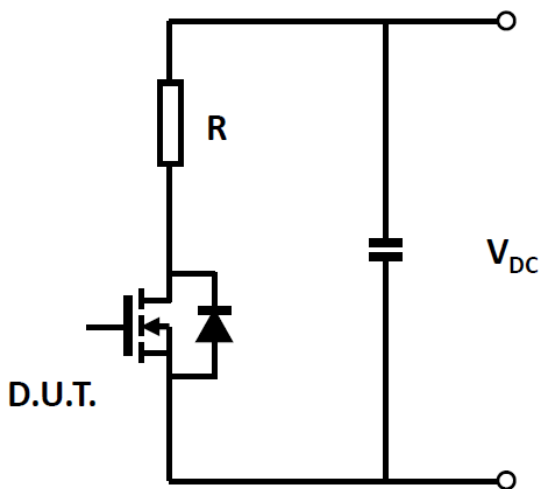


Figure 20. Schematic of Resistive Switching

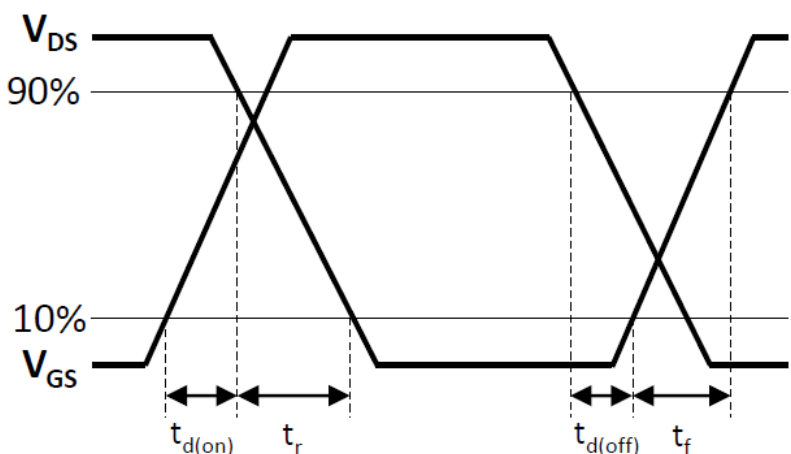
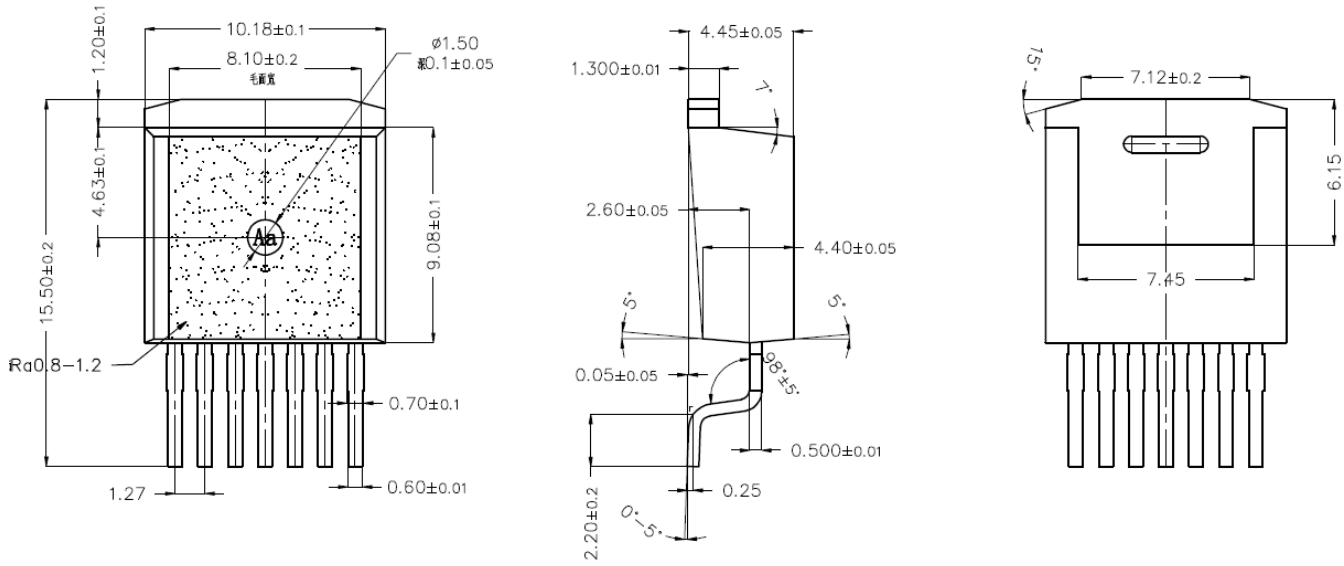


Figure 21. Switching Times Definition



■Outline Dimensions





Disclaimer

The information presented in this document is for reference only. Yangzhou Yangjie Electronic Technology Co., Ltd. reserves the right to make changes without notice for the specification of the products displayed herein to improve reliability, function or design or otherwise.

The product listed herein is designed to be used with ordinary electronic equipment or devices, and not designed to be used with equipment or devices which require high level of reliability and the malfunction of which would directly endanger human life (such as medical instruments, transportation equipment, aerospace machinery, nuclear-reactor controllers, fuel controllers and other safety devices), Yangjie or anyone on its behalf, assumes no responsibility or liability for any damages resulting from such improper use of sale.

This publication supersedes & replaces all information previously supplied. For additional information, please visit our website [http:// www.21yangjie.com](http://www.21yangjie.com) , or consult your nearest Yangjie's sales office for further assistance.